



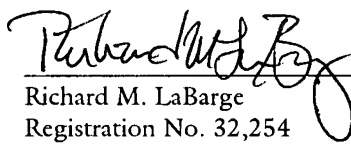
TFW

Applicant : Mark Leckenby  
Ser. No. : 10/516,903  
Filed : December 3, 2004  
Title : A Method for  
Determining Field  
Radiation Levels for a  
Radiating Device  
Art Unit : 3662  
Examiner : Alvarado

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) May 1, 2007

)   
) Richard M. LaBarge  
) Registration No. 32,254

### SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT (IDS)

*Commissioner for Patents  
P.O. Box 1450  
Alexandria, Virginia 22313-1450*

Dear Sir:

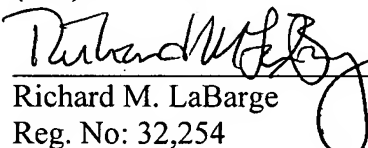
Pursuant to the duty of disclosure under 37 CFR §1.56, the documents identified on the enclosed PTO-1449 form are disclosed to the examiner for consideration in connection with the present application. Copies of the documents identified on the form are enclosed.

This disclosure is being made before the issuance of a first office action. Consequently, no fee is required.

Respectfully submitted,

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By:

  
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May 1, 2007

Form PTO-1449 (Modified)

**INFORMATION DISCLOSURE STATEMENT**

Atty. Docket No.

28159/40706

Serial No.

10/516,903

Applicant(s)

Leckenby, Mark

Filing Date (International Filing  
Date) June 5, 2003Art Unit  
3662**U.S. PATENT DOCUMENTS**

Examiner Initials	Document Number	Issue or Publication Date	Name	Class	Subclass	Filing Date (If Appropriate)

**FOREIGN PATENT DOCUMENTS**

Examiner Initials	Document Number	Publication Date	Country	Translation	
				Yes	No

**OTHER DOCUMENTS**

	Examination report issued by the New Zealand Patent Office dated February 7, 2005
	First examination report issued by the Indian Patent Office dated January 25, 2007
	Translation of the first examination report issued by the Chinese Patent Office
	Examination report issued by the Australian Patent Office dated April 15, 2004

EXAMINER:

DATE CONSIDERED: